

TOSHIBA FIELD EFFECT TRANSISTOR SILICON P CHANNEL MOS TYPE (L²-π-MOS V)

2SJ360

HIGH SPEED, HIGH CURRENT SWITCHING APPLICATIONS.

CHOPPER REGULATOR, DC-DC CONVERTER AND MOTOR DRIVE APPLICATIONS.

INDUSTRIAL APPLICATIONS

Unit in mm

- 4V GATE DRIVE
- Low Drain-Source ON Resistance : $R_{DS(ON)} = 0.55\Omega$ (Typ.)
- High Forward Transfer Admittance : $|Y_{fs}| = 0.9S$ (Typ.)
- Low Leakage Current : $I_{DSS} = -100\mu A$ (Max.) ($V_{DS} = -60V$)
- Enhancement-Mode : $V_{th} = -0.8 \sim -2.0V$
($V_{DS} = -10V, I_D = -1mA$)

MAXIMUM RATINGS (Ta = 25°C)

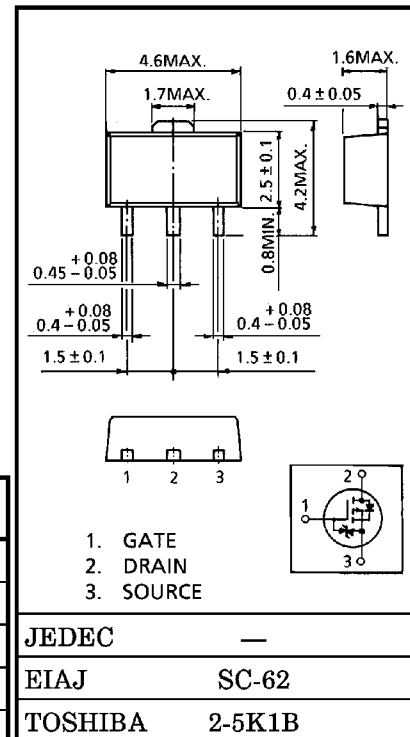
CHARACTERISTIC		SYMBOL	RATING	UNIT
Drain-Source Voltage		V_{DSS}	-60	V
Drain-Gate Voltage ($R_{GS} = 20k\Omega$)		V_{DGR}	-60	V
Gate-Source Voltage		V_{GSS}	± 20	V
Drain Current	DC	I_D	-1	A
	Pulse	I_{DP}	-3	A
Drain Power Dissipation ($T_c = 25^\circ C$)		P_D	0.5	W
Drain Power Dissipation		P_D^*	1.5	W
Channel Temperature		T_{ch}	150	°C
Storage Temperature Range		T_{stg}	-55~150	°C

P_D^* : Mounted on ceramic substrate (600mm²×0.8t)

THERMAL CHARACTERISTICS

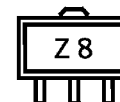
CHARACTERISTIC	SYMBOL	MAX.	UNIT
Thermal Resistance, Channel To Ambient	$R_{th(ch-a)}$	250	°C / W

THIS TRANSISTOR IS AN ELECTROSTATIC SENSITIVE DEVICE.
PLEASE HANDLE WITH CAUTION.



Weight : 0.05g

Marking



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● TOSHIBA is continually working to improve the quality and the reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to observe standards of safety, and to avoid situations in which a malfunction or failure of a TOSHIBA product could cause loss of human life, bodily injury or damage to property. In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent products specifications. Also, please keep in mind the precautions and conditions set forth in the TOSHIBA Semiconductor Reliability Handbook.

ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC		SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Gate Leakage Current		IGSS	VGS = ±16V, VDS = 0V	—	—	±10	μA
Drain Cut-off Current		IDSS	VDS = -60V, VGS = 0V	—	—	100	μA
Drain-Source Breakdown Voltage		V(BR)DSS	ID = -10mA, VGS = 0V	-60	—	—	V
Gate Threshold Voltage		Vth	VDS = -10V, ID = -1mA	-0.8	—	-2.0	V
Drain-Source ON Resistance		RDS(ON)	VGS = -4V, ID = -0.5A	—	0.86	1.2	Ω
			VGS = -10V, ID = -0.5A	—	0.55	0.73	
Forward Transfer Admittance		Yfs	VDS = -10V, ID = -0.5A	0.5	0.9	—	S
Input Capacitance		Ciss	VDS = -10V, VGS = 0V f = 1MHz	—	155	—	pF
Reverse Transfer Capacitance		Crss		—	20	—	
Output Capacitance		Coss		—	75	—	
Switching Time	Rise Time	tr	<p>VGS = 0V, -10V, ID = -0.5A, Vout, RL = 60Ω, VDD = -30V</p>	—	17	—	ns
	Turn-on Time	ton		—	20	—	
	Fall Time	tf		—	20	—	
	Turn-off Time	t _{off}		VIN : tr, tf < 5ns Duty ≤ 1%, tw = 10μs	—	100	
Total Gate Charge (Gate-Source Plus Gate-Drain)		Qg	VDD = -48V, VGS = -10V ID = -1A	—	6.5	—	nC
Gate-Source Charge		Qgs		—	4.5	—	
Gate-Drain ("Miller") Charge		Qgd		—	2.0	—	

SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Continuous Drain Reverse Current	IDR	—	—	—	-1	A
Pulse Drain Reverse Current	IDRP	—	—	—	-3	A
Diode Forward Voltage	VDSF	IDR = -1A, VGS = 0V	—	—	1.7	V
Reverse Recovery Time	t _{rr}	IDR = -1A, VGS = 0V	—	50	—	ns
Reverse Recovery Charge	Q _{rr}	dIDR / dt = 50A / μs	—	50	—	μC

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